

## Electronic supplementary information

### Three-dimensional hierarchical TiO<sub>2</sub> urchin as photoelectrochemical anode with omnidirectional anti-reflectance properties

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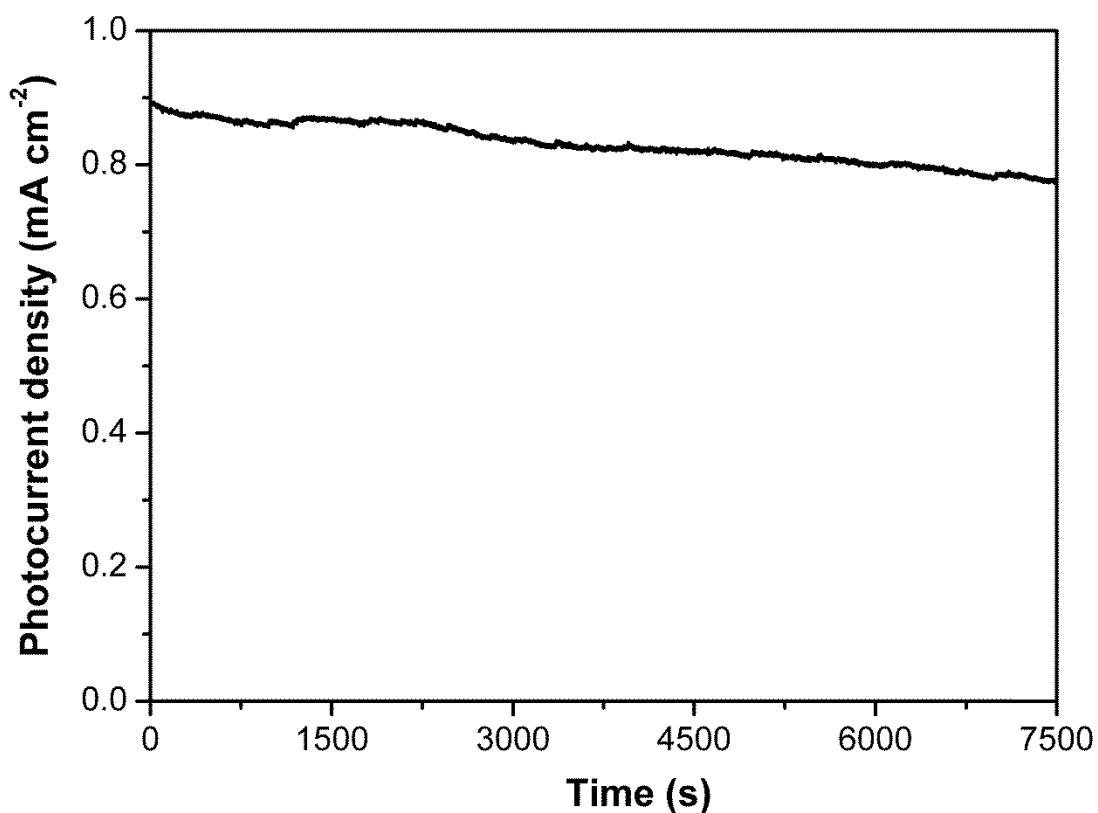


Figure S1 Long-term stability of TiO<sub>2</sub> urchin photoanode under continuous light illumination

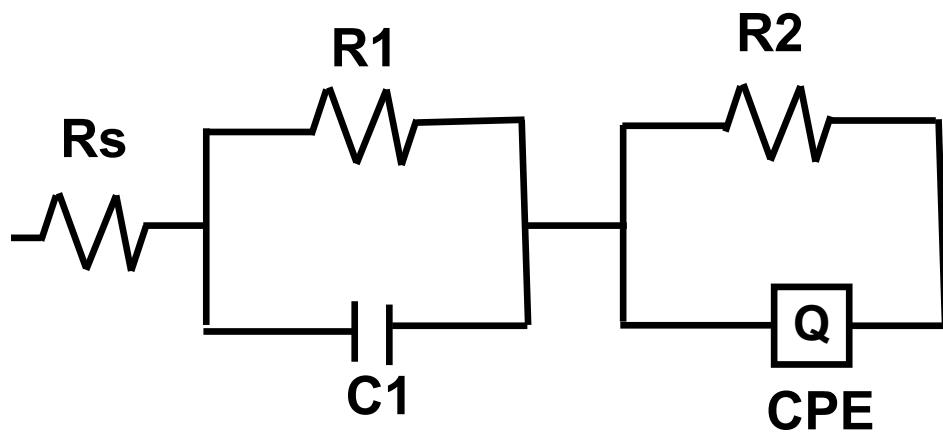


Figure S2 Equivalent circuits used to fit the EIS response of the  $\text{TiO}_2$  urchin and microspheres photoanodes under illumination.

$R_s$  working medium resistance

$R_1$  charge transfer resistance between  $\text{TiO}_2/\text{FTO}$  interface.

$C_1$   $\text{TiO}_2$  capacitance, including surface state and Helmholtze double layer

$R_2$  charge transfer resistance between  $\text{TiO}_2/\text{electrolyte}$  interface

CPE constant phase element defined by CPE.

Table 1 Parameters of the Equivalent—Circuit components that are used to model the  $\text{TiO}_2$  microspheres and  $\text{TiO}_2$  urchin electrodes.

Parameters	$R_s$	$C_1$	$R_1$	CPE	$R_2$
$\text{TiO}_2$ microspheres	20.59 $\Omega$	0.14 mF $\text{cm}^{-2}$	2139 $\Omega$	0.001507	1109 $\Omega$
$\text{TiO}_2$ urchin	20.87 $\Omega$	0.76 mF $\text{cm}^{-2}$	16.14 $\Omega$	7.002E-9	49.7 $\Omega$
Errors (microspheres)	5.53%	3.49%	4.68%	14.37%	3.92%
Errors (urchin)	6.53%	3.09%	5.61%	10%	3.63%